### The 22<sup>nd</sup> Korean Conference on Semiconductors (KCS 2015)

## 제22회 한국반도체학술대회

2015년 2월 10일(화)-12일(목), 인천 송도컨벤시아

### D. Thin Film Process Technology 분과

Room D 1F / 107호

#### 2015년 2월 12일(목) 13:10-14:40

#### [TD2-D] Oxide Semiconductor & 2D Dichalcogenide Thin-Film Transistor Technologies

TD2-D-1	13:10-13:25	Device Characterizations on the Performance and Stabilities of InGaZnO
		Thin Film Transistors Fabricated on Flexible Polyethylene Naphthalate
		Minji Park <sup>1</sup> , Jun-Yong Bak <sup>1</sup> , Min-Ki Ryu <sup>2</sup> , Jong-Heon Yang <sup>2</sup> , Gi Heon Kim <sup>2</sup> ,
		Sung-Min Yoon <sup>1</sup>
		<sup>1</sup> Kyung Hee University, <sup>2</sup> Electronics & Telecommunication Research Institute
TD2-D-2	13:25-13:40	Fully-Transparent Nonvolatile Memory Thin-Film Transistors Using
		Organic/Inorganic Hybrid Gate-Stack with Double-Gate Configuration
		Da-Bin Jeon and Sung-Min Yoon
		Department of Advanced Materials Engineering for Information and
		Electronics, Kyung Hee University
TD2-D-3	13:40-13:55	Nonvolatile Memory Performances of Transparent Memory Thin-Film
		Transistors Using IGZO Channel and ZnO Charge-Trap Layers
		Sojung Kim, Jun-Yong Bak, and Sung-Min Yoon
		Department of Advanced Materials Engineering for Information and
		Electronics, Kyung Hee University
TD2-D-4	13:55-14:10	Growth of MoS <sub>2</sub> Thin Films by Atomic Layer Deposition
		Jung Joon Pyeon <sup>1,2</sup> , Cheol Jin Cho <sup>2,3</sup> , Soo Hyun Kim <sup>1</sup> , Chong Yun Kang <sup>1,2</sup> , and
		Seong Keun Kim <sup>2</sup>
		<sup>1</sup> KU-KIST Graduate school of Converging Science and Technology, <sup>2</sup> Electronic
		Material Center, Korea Institute of Science and Technology, <sup>3</sup> Department of
		Materials Science and Engineering and Interuniversity Semiconductor
		Research Center, Seoul National Unive
TD2-D-5	14:10-14:25	Synthesis of Wafer-Scale Layer Controlled Molybdenum Disulfide using
		Atomic Layer Deposition
		Youngjun Kim <sup>1</sup> , Jeong-Gyu Song <sup>1</sup> , GyeongHee Ryu <sup>2</sup> , Sung-Hwan Hwang <sup>3</sup> ,
		Chang Wan Lee <sup>1</sup> , Taejin Choi <sup>1</sup> , Whang Je Woo <sup>1</sup> , Hanearl Jung <sup>1</sup> , Zonghoon
		Lee <sup>2</sup> , Jae-Min Myoung <sup>3</sup> , Jong-Hyun Ahn <sup>1</sup> , Jusang Park <sup>1</sup> , and Hyungjun Kim <sup>1</sup>
		<sup>1</sup> School of Electrical and Electronic Engineering, Yonsei University, <sup>2</sup> School of
		Materials Science and Engineering, Ulsan National Institute of Science and
		Technology (UNIST), <sup>3</sup> Department of Materials Science and Engineering,
		Yonsei University

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#### TD2-D-6 14:25-14:40 MoS<sub>2</sub> 전계효과 트랜지스터의 컨택 저항 개선 방법

박우진, 김용훈, 이상경, 정욱진, 양진호, 조천흠, 김윤지, 임성관, 이병훈 Center for Emerging Electric Devices and Systems, School of Material Science and Engineering, Gwangju Institute of Science and Technology